

2SK3628

Silicon N-channel power MOSFET

For high-speed switching

■ Features

- Avalanche energy capability guaranteed
- High-speed switching
- Low ON resistance R_{on}
- No secondary breakdown

■ Absolute Maximum Ratings $T_C = 25^\circ\text{C}$

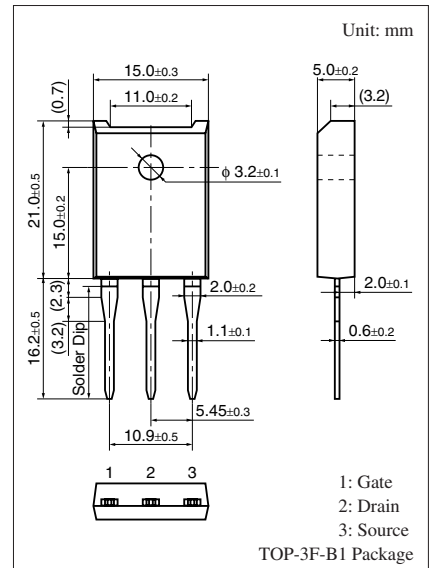
Parameter	Symbol	Rating	Unit
Drain-source surrender voltage	V_{DSS}	230	V
Gate-source surrender voltage	V_{GSS}	± 30	V
Drain current	I_D	20	A
Peak drain current	I_{DP}	80	A
Avalanche energy capability *	EAS	570	mJ
Power dissipation	P_D	100	W
	$T_a = 25^\circ\text{C}$	3	
Channel temperature	T_{ch}	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

Note) *: $L = 2.23\text{ mH}$, $I_L = 20\text{ A}$, $V_{DD} = 50\text{ V}$, 1 pulse, $T_a = 25^\circ\text{C}$

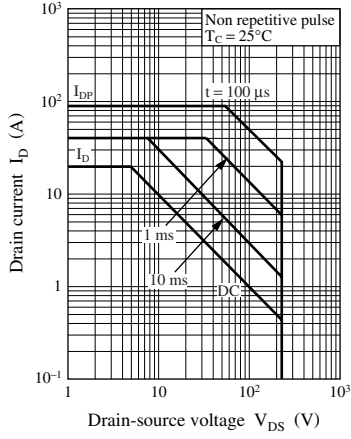
■ Electrical Characteristics $T_C = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Gate-drain surrender voltage	V_{DSS}	$I_D = 1\text{ mA}$, $V_{GS} = 0$	230			V
Diode forward voltage	V_{DSF}	$I_{DR} = 20\text{ A}$, $V_{GS} = 0$			-1.5	V
Gate threshold voltage	V_{th}	$V_{DS} = 25\text{ V}$, $I_D = 1\text{ mA}$	1.7		3.7	V
Drain-source cutoff current	I_{DSS}	$V_{DS} = 184\text{ V}$, $V_{GS} = 0$			100	μA
Gate-source cutoff current	I_{GSS}	$V_{GS} = \pm 30\text{ V}$, $V_{DS} = 0$			± 1	μA
Drain-source on resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$, $I_D = 10\text{ A}$		65	85	$\text{m}\Omega$
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 25\text{ V}$, $I_D = 10\text{ A}$	7	14		S
Short-circuit forward transfer capacitance (Common-source)	C_{iss}	$V_{DS} = 25\text{ V}$, $V_{GS} = 0$, $f = 1\text{ MHz}$		2300		pF
Short-circuit output capacitance (Common-source)	C_{oss}			330		pF
Reverse transfer capacitance (Common-source)	C_{rss}			30		pF
Turn-on delay time	$t_{d(on)}$	$V_{DD} \approx 100\text{ V}$, $I_D = 15\text{ A}$ $R_L = 6.7\ \Omega$, $V_{GS} = 10\text{ V}$		35		ns
Rise time	t_r			26		ns
Turn-off delay time	$t_{d(off)}$			220		ns
Fall time	t_f			36		ns

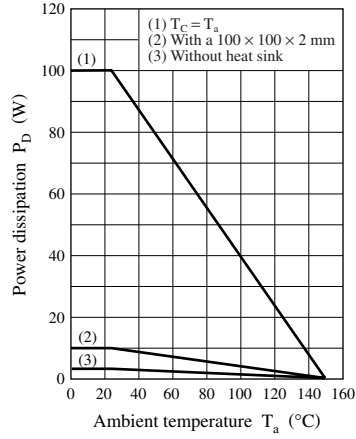
Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.



Safe operation area



$P_D - T_a$



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